

<b>Notice of References Cited</b>	Application/Control No. 09/892,312	Applicant(s)/Patent Under Reexamination LEE, SIEW FEI	
	Examiner Kevin M. Nguyen	Art Unit 2674	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,256,931	03-1981	Palisek, William F.	200/5A
*	B	US-5,498,843	03-1996	Date et al.	200/6A
*	C	US-5,670,955	09-1997	Thorne et al.	341/34
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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